

1N65

Power MOSFET

1.2A, 650V N-CHANNEL POWER MOSFET

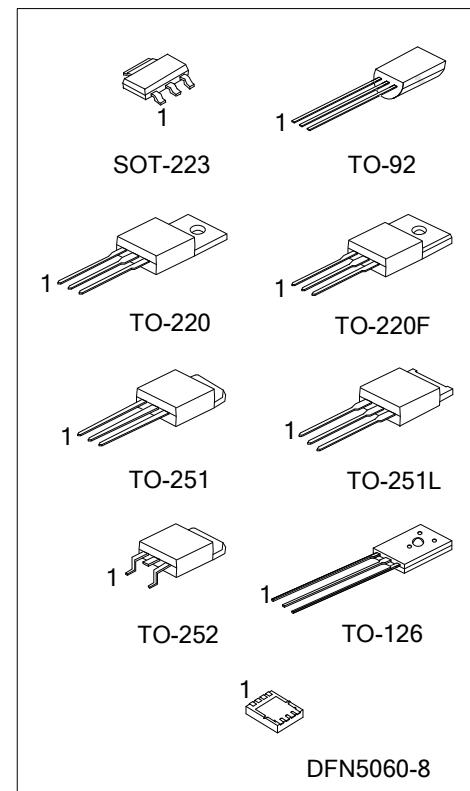
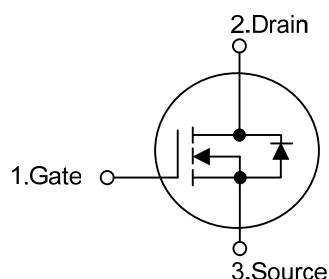
■ DESCRIPTION

The UTC 1N65 is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in the high speed switching applications of power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

■ FEATURES

- * $R_{DS(ON)} < 12.5\Omega$ @ $V_{GS} = 10V$, $I_D = 0.6A$
- * Ultra Low gate charge (typical 5.0nC)
- * Low reverse transfer capacitance (C_{RSS} = typical 3.0 pF)
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

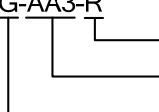
■ SYMBOL



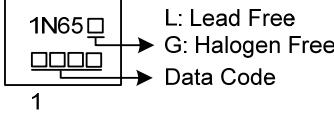
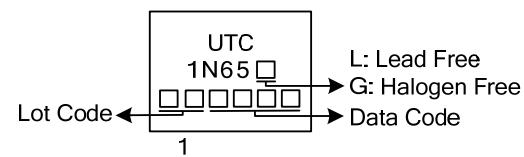
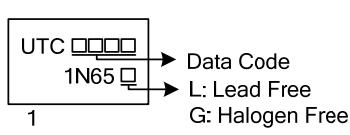
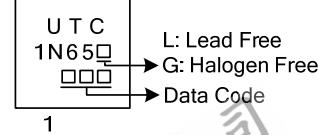
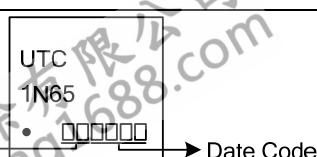
■ ORDERING INFORMATION

Ordering Number	Package	Pin Assignment								Packing
		1	2	3	4	5	6	7	8	
Lead Free	Halogen Free									
1N65L-AA3-R	1N65G-AA3-R	SOT-223	G	D	S	-	-	-	-	Tape Reel
1N65L-TA3-T	1N65G-TA3-T	TO-220	G	D	S	-	-	-	-	Tube
1N65L-TF3-T	1N65G-TF3-T	TO-220F	G	D	S	-	-	-	-	Tube
1N65L-TM3-T	1N65G-TM3-T	TO-251	G	D	S	-	-	-	-	Tube
1N65L-TMA-T	1N65G-TMA-T	TO-251L	G	D	S	-	-	-	-	Tube
1N65L-TN3-R	1N65G-TN3-R	TO-252	G	D	S	-	-	-	-	Tape Reel
1N65L-T60-K	1N65G-T60-K	TO-126	G	D	S	-	-	-	-	Bulk
1N65L-T92-B	1N65G-T92-B	TO-92	G	D	S	-	-	-	-	Tape Box
1N65L-T92-K	1N65G-T92-K	TO-92	G	D	S	-	-	-	-	Bulk
1N65L-K08-5060-R	1N65G-K08-5060-R	DFN5060-8	S	S	S	G	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

 (1)Packing Type (2)Package Type (3)Green Package	(1) B: Tape Box, K: Bulk, T: Tube, R: Tape Reel (2) AA3: SOT-223, T92: TO-92, TA3: TO-220, TF3: TO-220F, TM3: TO-251, TN3: TO-252 TMA: TO-251L, T60: TO-126, K08-5060: DFN5060-8 (3) G: Halogen Free and Lead Free, L: Lead Free
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■ MARKING

PACKAGE	MARKING
SOT-223	 1
TO-220 TO-220F TO-251 TO-251L TO-252	 1
TO-126	 1
TO-92	 1
DFN5060-8	 1

■ ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DSS}	650	V
Gate-Source Voltage	V_{GSS}	± 30	V
Avalanche Current (Note 2)	I_{AR}	1.2	A
Continuous Drain Current	I_D	1.2	A
Pulsed Drain Current (Note 2)	I_{DM}	4.8	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	50 mJ
	Repetitive (Note 2)	E_{AR}	4.0 mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	4.5 V/ns	
Power Dissipation	SOT-223	P_D	8 W
	TO-251/TO-251L		28 W
	TO-252		40 W
	TO-220		21 W
	TO-220F		1 W
	TO-92 ($T_A=25^\circ\text{C}$)		12.5 W
	TO-126		14 W
	DFN5060-8		
Junction Temperature	T_J	+150	$^\circ\text{C}$
Operating Temperature	T_{OPR}	-55 ~ +150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature

3. $L = 60\text{mH}$, $I_{AS} = 1\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$

4. $I_{SD} \leq 1.2\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	SOT-223	θ_{JA}	$^\circ\text{C/W}$
	TO-220/TO-220F		
	TO-251/TO-251L		
	TO-252		
	TO-92		
	TO-126		
	DFN5060-8		
Junction to Case	SOT-223	θ_{JC}	$^\circ\text{C/W}$
	TO-220		
	TO-220F		
	TO-251/TO-251L		
	TO-252		
	TO-92		
	TO-126		
	DFN5060-8		

■ ELECTRICAL CHARACTERISTICS ($T_c=25^\circ\text{C}$, unless otherwise specified.)

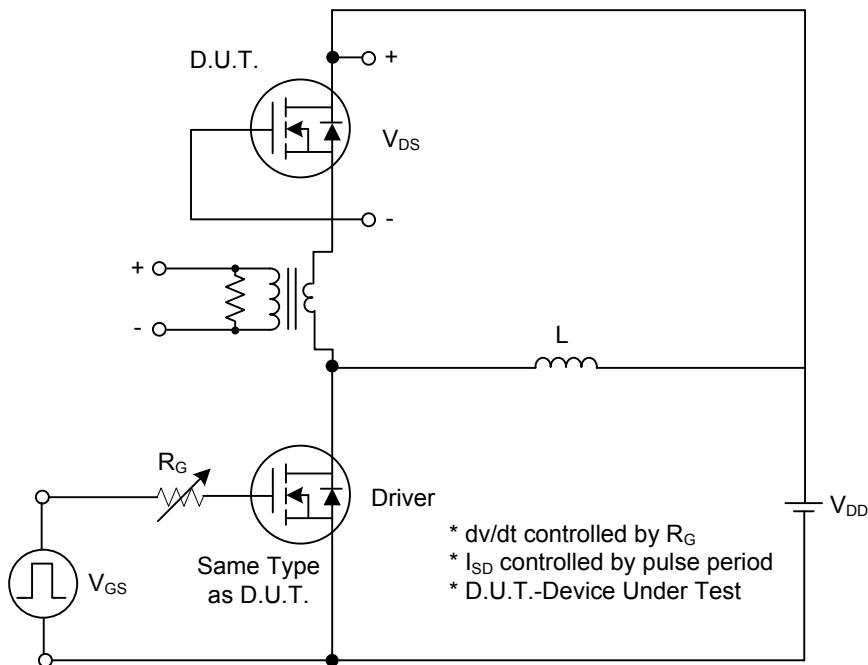
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	650			V
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=650\text{V}, V_{\text{GS}}=0\text{V}$		10		μA
Gate-Source Leakage Current	Forward	$V_{\text{GS}}=30\text{V}, V_{\text{DS}}=0\text{V}$		100		nA
	Reverse	$V_{\text{GS}}=-30\text{V}, V_{\text{DS}}=0\text{V}$		-100		nA
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	$I_{\text{D}}=250\mu\text{A}$		0.4		V°C
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{\text{GS}(\text{TH})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0		4.0	V
Static Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=0.6\text{A}$		9.5	12.5	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$		120	150	pF
Output Capacitance	C_{OSS}			20	25	pF
Reverse Transfer Capacitance	C_{RSS}			3.0	4.0	pF
SWITCHING CHARACTERISTICS						
Total Gate Charge	Q_G	$V_{\text{DS}}=520\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=1.2\text{A}$ (Note 2,3)		5.0	6.0	nC
Gate-Source Charge	Q_{GS}			1.0		nC
Gate-Drain Charge	Q_{GD}			2.6		nC
Turn-On Delay Time	$t_{\text{D}(\text{ON})}$	$V_{\text{DD}}=325\text{V}, I_{\text{D}}=1.2\text{A}, R_{\text{G}}=50\Omega$ (Note 2,3)		5	20	ns
Turn-On Rise Time	t_R			25	60	ns
Turn-Off Delay Time	$t_{\text{D}(\text{OFF})}$			7	25	ns
Turn-Off Fall Time	t_F			25	60	ns
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I_S				1.2	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				4.8	A
Drain-Source Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=1.2\text{A}$			1.4	V
Reverse Recovery Time	t_{rr}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=1.2\text{A}$		160		ns
Reverse Recovery Charge	Q_{rr}	$dI_F/dt=100\text{A}/\mu\text{s}$ (Note 1)		0.3		μC

Note: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

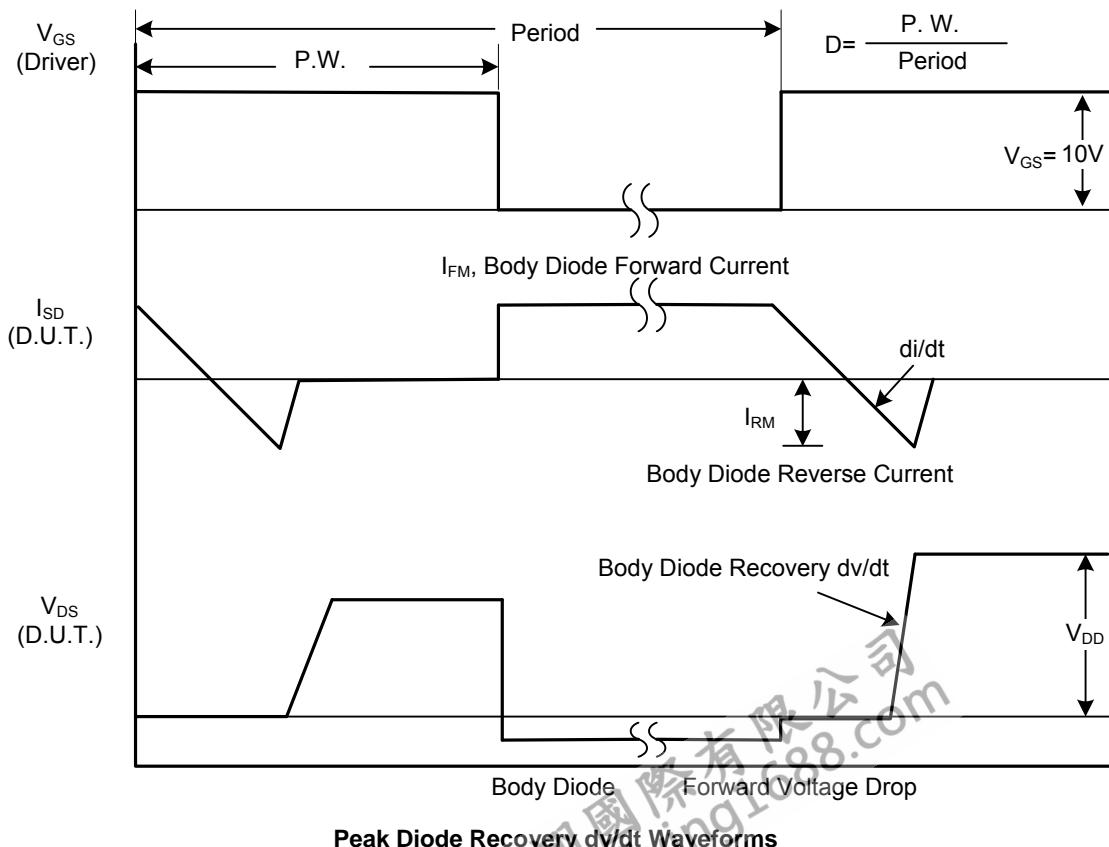
2. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

3. Essentially Independent of Operating Temperature

■ TEST CIRCUITS AND WAVEFORMS

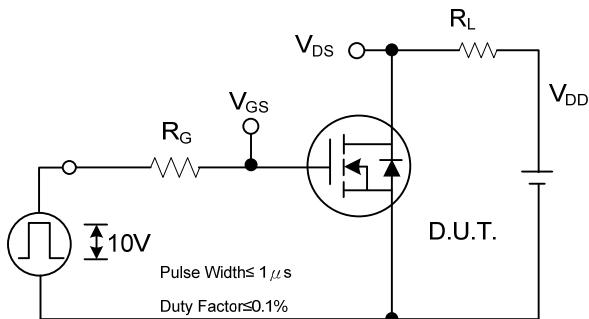


Peak Diode Recovery dv/dt Test Circuit

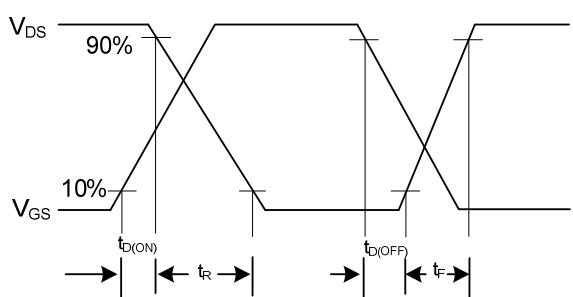


Peak Diode Recovery dv/dt Waveforms

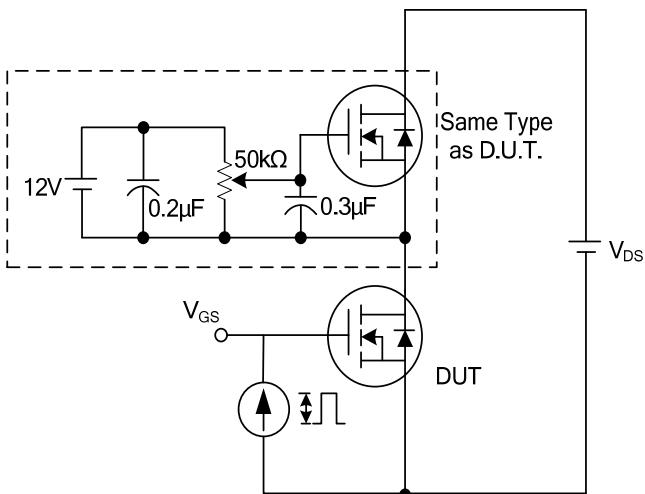
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



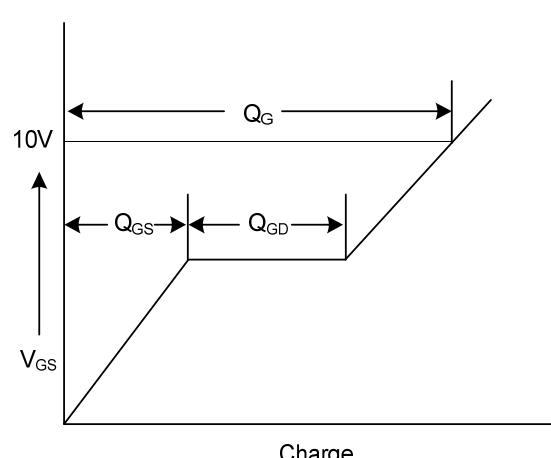
Switching Test Circuit



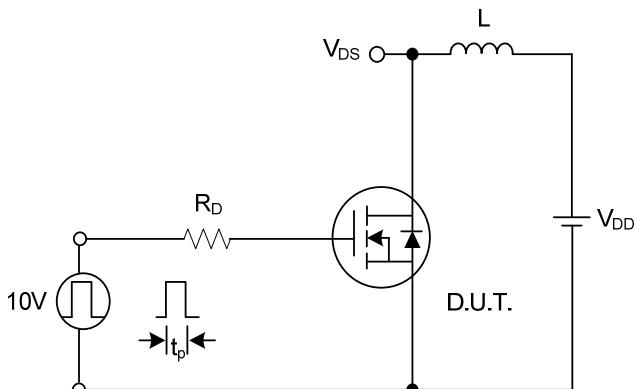
Switching Waveforms



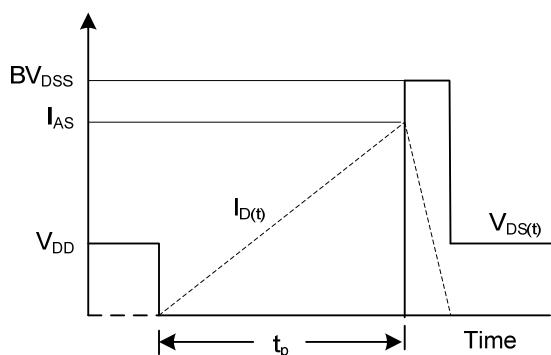
Gate Charge Test Circuit



Gate Charge Waveform

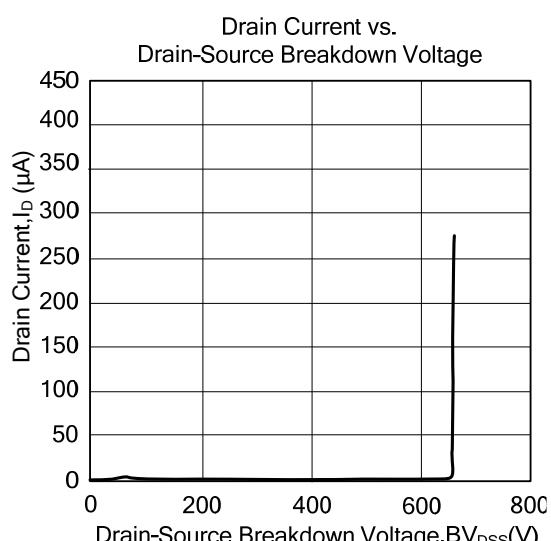
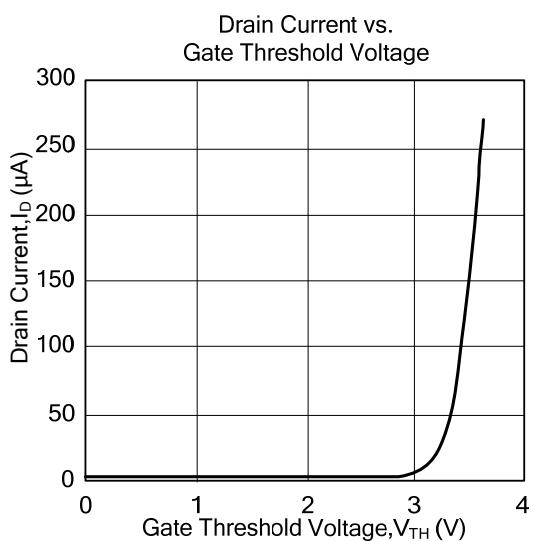
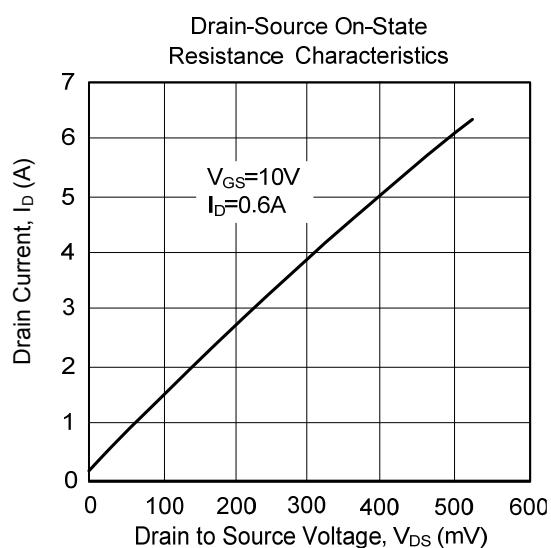
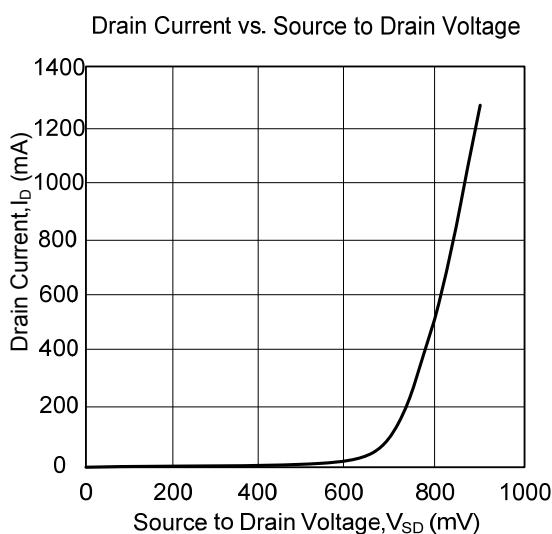


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveform

■ TYPICAL CHARACTERISTICS



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